


<b>Search Notes</b>  	<b>Application/Control No.</b>  10016867	<b>Applicant(s)/Patent Under Reexamination</b>  SHAFFER ET AL.
	<b>Examiner</b>  Nguyen, Toan D	<b>Art Unit</b>  2616

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SEARCH NOTES		
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EAST (US-PGPUB;USPAT;EPO;IBM_TDB)	10/03/07	TN
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